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450100-04677

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants: Takuji HIMENO et al.
International Application No.: PCT/JP03/08432
International Filing Date: July 2, 2003
For: IMAGE DATA PROCESSING APPARATUS AND
METHOD

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Enclosed are copies of the publications, which were cited in the International Search Report of International Application No. PCT/JP03/08432. Also enclosed is a copy of Form PTO-1449 and the International Search Report.

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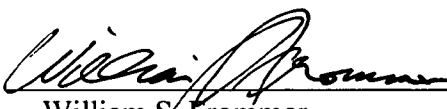
REMARKS

Entry of this Information Disclosure Statement and an early examination on the merits are respectfully solicited.

Please charge any additional fees to Deposit Account No. 50-0320.

Respectfully submitted,

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Enclosures

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